

Search Notes

Application No.

10/024,857

Examiner

Thuy Pardo

Applicant(s)

WALLACH ET AL.

Art Unit

2175

SEARCHED			
Class	Subclass	Date	Examiner
707	3		
	102		
705	2		
435	6		
600	589		
702	19		
706	21		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**WEST
IEEE

7/10/04

187

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner